CM100RX-24S1

HIGH POWER SWITCHING USE
INSULATED TYPE

sevenpack (3φ Inverter + Brake Chopper)

Collector current I_C 100A
Collector-emitter voltage V_{CES} 1200V
Maximum junction temperature T_{jmax} ..... 175°C

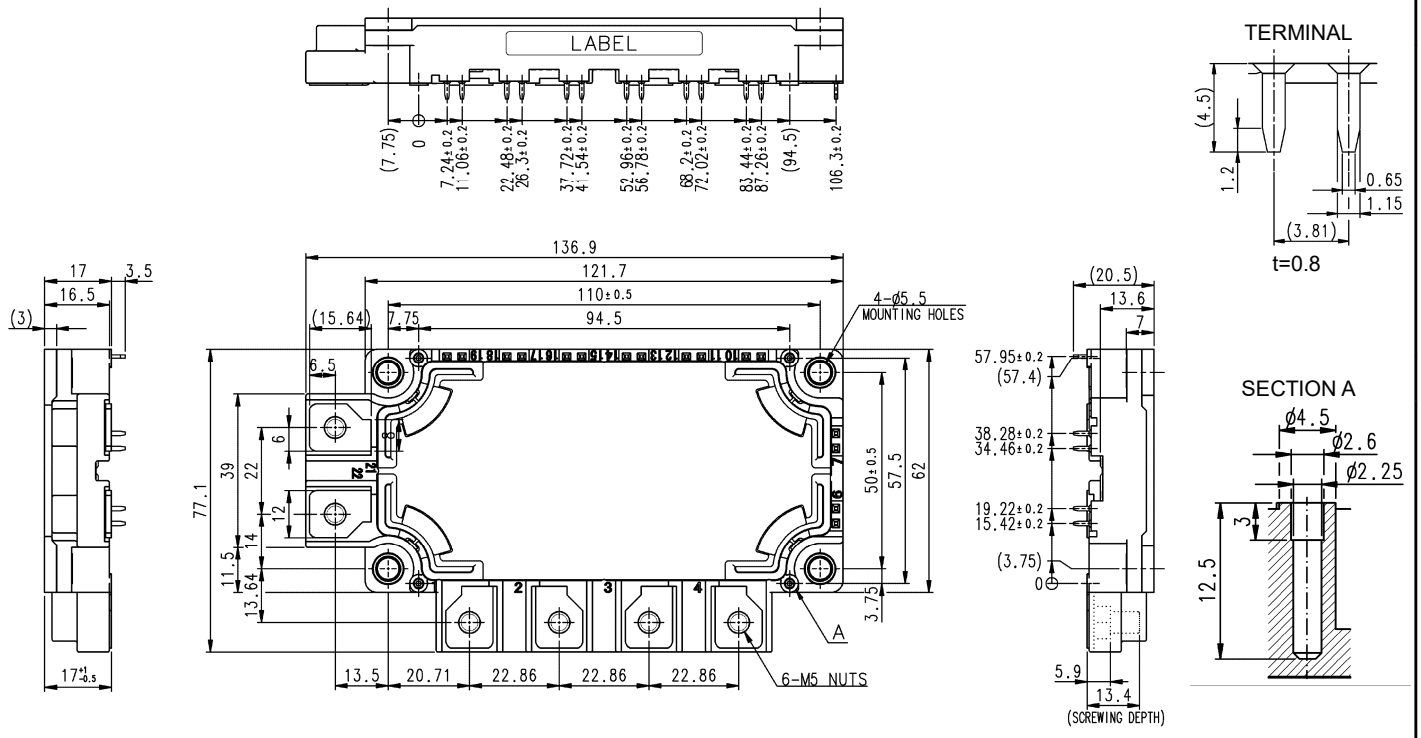
- Flat base Type
- Copper base plate (non-plating)
- Tin plating pin terminals
- RoHS Directive* compliant
- Recognized under UL1557, File E323585

APPLICATION

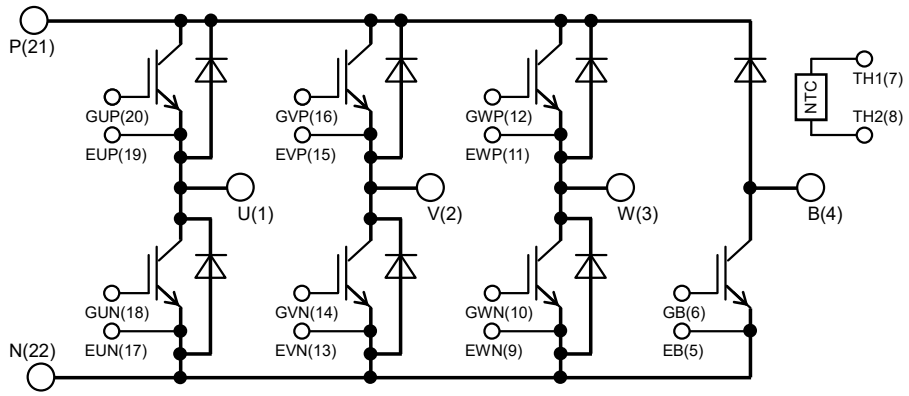
AC Motor Control, Motion/Servo Control, etc.

OUTLINE DRAWING & INTERNAL CONNECTION

Dimension in mm



INTERNAL CONNECTION



Tolerance otherwise specified

Division of Dimension		Tolerance
0.5	to 3	±0.2
over 3	to 6	±0.3
over 6	to 30	±0.5
over 30	to 120	±0.8
over 120	to 400	±1.2

CM100RX-24S1

HIGH POWER SWITCHING USE
INSULATED TYPE

MAXIMUM RATINGS (T_j=25 °C, unless otherwise specified)

INVERTER PART IGBT/DIODE

Symbol	Item	Conditions	Rating	Unit
V_{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I_C	Collector current	DC, T_C=107 °C (Note2, 4)	100	A
I_{CRM}		Pulse, Repetitive (Note3)	200	
P_{tot}	Total power dissipation	T_C=25 °C (Note2, 4)	625	W
I_E (Note1)	Emitter current	DC (Note2)	100	A
I_{ERM} (Note1)		Pulse, Repetitive (Note3)	200	

BRAKE PART IGBT/DIODE

Symbol	Item	Conditions	Rating	Unit
V_{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I_C	Collector current	DC, T_C=113 °C (Note2, 4)	50	A
I_{CRM}		Pulse, Repetitive (Note3)	100	
P_{tot}	Total power dissipation	T_C=25 °C (Note2, 4)	340	W
V_{RRM}	Repetitive peak reverse voltage	G-E short-circuited	1200	V
I_F	Forward current	DC (Note2)	50	A
I_{FRM}		Pulse, Repetitive (Note3)	100	

MODULE

Symbol	Item	Conditions	Rating	Unit
V_{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V
T_{jmax}	Maximum junction temperature	Instantaneous event (overload)	175	°C
T_{Cmax}	Maximum case temperature	(Note4)	125	
T_{jop}	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	°C
T_{stg}	Storage temperature	-	-40 ~ +125	

ELECTRICAL CHARACTERISTICS (T_j=25 °C, unless otherwise specified)

INVERTER PART IGBT/DIODE

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
I_{CES}	Collector-emitter cut-off current	V_{CE}=V_{CES}, G-E short-circuited		-	-	1.0	mA
I_{GES}	Gate-emitter leakage current	V_{GE}=V_{GES}, C-E short-circuited		-	-	0.5	μA
$V_{GE(th)}$	Gate-emitter threshold voltage	I_C=10 mA, V_{CE}=10 V		5.4	6.0	6.6	V
V_{CEsat} (Terminal)	Collector-emitter saturation voltage	I_C=100 A, V_{GE}=15 V, Refer to the figure of test circuit (Note5)	T_j=25 °C	-	1.80	2.25	V
			T_j=125 °C	-	2.00	-	
			T_j=150 °C	-	2.05	-	
V_{CEsat} (Chip)		I_C=100 A, V_{GE}=15 V, (Note5)	T_j=25 °C	-	1.70	2.15	V
			T_j=125 °C	-	1.90	-	
			T_j=150 °C	-	1.95	-	
C_{ies}	Input capacitance	V_{CE}=10 V, G-E short-circuited		-	-	10	nF
C_{oes}	Output capacitance			-	-	2.0	
C_{res}	Reverse transfer capacitance			-	-	0.17	
Q_G	Gate charge	V_{CC}=600 V, I_C=100 A, V_{GE}=15 V		-	210	-	nC
$t_{d(on)}$	Turn-on delay time	V_{CC}=600 V, I_C=100 A, V_{GE}=±15 V, R_G=6.2 Ω, Inductive load		-	-	300	ns
t_r	Rise time			-	-	200	
$t_{d(off)}$	Turn-off delay time			-	-	600	
t_f	Fall time			-	-	300	

ELECTRICAL CHARACTERISTICS (cont.; T_j=25 °C, unless otherwise specified)

INVERTER PART IGBT/DIODE

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
V_{EC} (Note1) (Terminal)	Emitter-collector voltage	I_E=100 A, G-E short-circuited, Refer to the figure of test circuit (Note5)	T_j=25 °C	-	2.60	3.40	V
			T_j=125 °C	-	2.16	-	
			T_j=150 °C	-	2.10	-	
V_{EC} (Note1) (Chip)		I_E=100 A, G-E short-circuited, (Note5)	T_j=25 °C	-	2.50	3.30	V
			T_j=125 °C	-	2.06	-	
			T_j=150 °C	-	2.00	-	
t_{rr} (Note1)	Reverse recovery time	V_{CC}=600 V, I_E=100 A, V_{GE}=±15 V, R_G=6.2 Ω, Inductive load		-	-	300	ns
Q_{rr} (Note1)	Reverse recovery charge			-	2.7	-	μC
E_{on}	Turn-on switching energy per pulse	V_{CC}=600 V, I_C=I_E=100 A, V_{GE}=±15 V, R_G=6.2 Ω, T_j=150 °C, Inductive load		-	5.9	-	mJ
E_{off}	Turn-off switching energy per pulse			-	9.7	-	
E_{rr} (Note1)	Reverse recovery energy per pulse			-	9.7	-	mJ
$R_{CC'+EE'}$	Internal lead resistance	Main terminals-chip, per switch, T_C=25 °C (Note4)		-	-	0.8	mΩ
r_g	Internal gate resistance	Per switch		-	0	-	Ω

BRAKE PART IGBT/DIODE

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
I_{CES}	Collector-emitter cut-off current	V_{CE}=V_{CES}, G-E short-circuited		-	-	1.0	mA
I_{GES}	Gate-emitter leakage current	V_{GE}=V_{GES}, C-E short-circuited		-	-	0.5	μA
$V_{GE(th)}$	Gate-emitter threshold voltage	I_C=5 mA, V_{CE}=10 V		5.4	6.0	6.6	V
V_{CEsat} (Terminal)	Collector-emitter saturation voltage	I_C=50 A, V_{GE}=15 V, Refer to the figure of test circuit (Note5)	T_j=25 °C	-	1.80	2.25	V
			T_j=125 °C	-	2.00	-	
			T_j=150 °C	-	2.05	-	
V_{CEsat} (Chip)		I_C=50 A, V_{GE}=15 V, (Note5)	T_j=25 °C	-	1.70	2.15	V
			T_j=125 °C	-	1.90	-	
			T_j=150 °C	-	1.95	-	
C_{ies}	Input capacitance	V_{CE}=10 V, G-E short-circuited		-	-	5.0	nF
C_{oes}	Output capacitance			-	-	1.0	
C_{res}	Reverse transfer capacitance			-	-	0.08	
Q_G	Gate charge	V_{CC}=600 V, I_C=50 A, V_{GE}=15 V		-	105	-	nC
$t_{d(on)}$	Turn-on delay time	V_{CC}=600 V, I_C=50 A, V_{GE}=±15 V, R_G=13 Ω, Inductive load		-	-	300	ns
t_r	Rise time			-	-	200	
$t_{d(off)}$	Turn-off delay time			-	-	600	
t_f	Fall time			-	-	300	
I_{RRM}	Repetitive peak reverse current	V_R=V_{RRM}, G-E short-circuited		-	-	1.0	mA
V_F (Terminal)	Forward voltage	I_E=50 A, G-E short-circuited, Refer to the figure of test circuit (Note5)	T_j=25 °C	-	2.60	3.40	V
			T_j=125 °C	-	2.16	-	
			T_j=150 °C	-	2.10	-	
V_F (Chip)		I_E=50 A, G-E short-circuited, (Note5)	T_j=25 °C	-	2.50	3.30	V
			T_j=125 °C	-	2.06	-	
			T_j=150 °C	-	2.00	-	
t_{rr}	Reverse recovery time	V_{CC}=600 V, I_E=50 A, V_{GE}=±15 V, R_G=13 Ω, Inductive load		-	-	300	ns
Q_{rr}	Reverse recovery charge			-	1.3	-	μC
E_{on}	Turn-on switching energy per pulse	V_{CC}=600 V, I_C=I_E=50 A, V_{GE}=±15 V, R_G=13 Ω, T_j=150 °C, Inductive load		-	3.2	-	mJ
E_{off}	Turn-off switching energy per pulse			-	5.0	-	
E_{rr}	Reverse recovery energy per pulse			-	4.4	-	mJ
r_g	Internal gate resistance	-		-	0	-	Ω

ELECTRICAL CHARACTERISTICS (cont.; T_j=25 °C, unless otherwise specified)

NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R_{25}	Zero-power resistance	T_C=25 °C (Note4)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	R_{100}=493 Ω, T_C=100 °C (Note4)	-7.3	-	+7.8	%
$B_{(25/50)}$	B-constant	Approximate by equation (Note6)	-	3375	-	K
P_{25}	Power dissipation	T_C=25 °C (Note4)	-	-	10	mW

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per Inverter IGBT (Note4)	-	-	0.24	K/W
$R_{th(j-c)D}$		Junction to case, per Inverter DIODE (Note4)	-	-	0.37	
$R_{th(j-c)Q}$		Junction to case, per Brake IGBT (Note4)	-	-	0.44	K/W
$R_{th(j-c)D}$		Junction to case, per Brake DIODE (Note4)	-	-	0.66	
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink, per 1 module, Thermal grease applied (Note4, 7)	-	15	-	K/kW

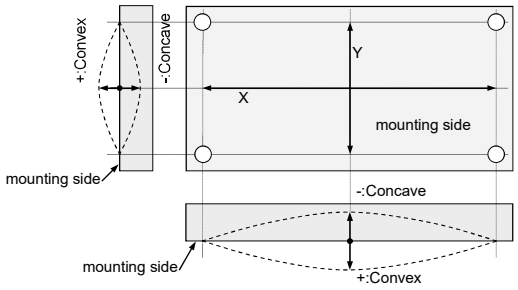
MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
M_t	Mounting torque	Main terminals M 5 screw	2.5	3.0	3.5	N·m
M_s	Mounting torque	Mounting to heat sink M 5 screw	2.5	3.0	3.5	N·m
d_s	Creepage distance	Terminal to terminal	17	-	-	mm
		Terminal to base plate	20.1	-	-	
d_a	Clearance	Terminal to terminal	10	-	-	mm
		Terminal to base plate	14.8	-	-	
m	mass	-	-	370	-	g
e_c	Flatness of base plate	On the centerline X, Y (Note8)	±0	-	+100	μm

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (DIODE).

2. Junction temperature (T_j) should not increase beyond T_{jmax} rating.
3. Pulse width and repetition rate should be such that the device junction temperature (T_j) dose not exceed T_{jmax} rating.
4. Case temperature (T_C) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
5. Pulse width and repetition rate should be such as to cause negligible temperature rise.
6. $B_{(25/50)} = \ln(\frac{R_{25}}{R_{50}}) / (\frac{1}{T_{25}} - \frac{1}{T_{50}})$,

   R_{25}: resistance at absolute temperature T_{25} [K]; T_{25}=25 [°C]+273.15=298.15 [K]
   R_{50}: resistance at absolute temperature T_{50} [K]; T_{50}=50 [°C]+273.15=323.15 [K]
7. Typical value is measured by using thermally conductive grease of λ=0.9 W/(m·K).
8. The base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.



9. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.
PCB thickness : t=1.6.

	Type	Size	Tightening torque	Recommended tightening method
(1)	PT®	K25×8	0.55 ± 0.055 N▪m	by handwork (equivalent to 30 rpm by mechanical screw driver) ~ 600 rpm (by mechanical screw driver)
(2)	PT®	K25×10	0.75 ± 0.075 N▪m	
(3)	DELTA PT®	25×8	0.55 ± 0.055 N▪m	
(4)	DELTA PT®	25×10	0.75 ± 0.075 N▪m	
(5)	B1 tapping screw	φ2.6×10 or φ2.6×12	0.75 ± 0.075 N▪m	

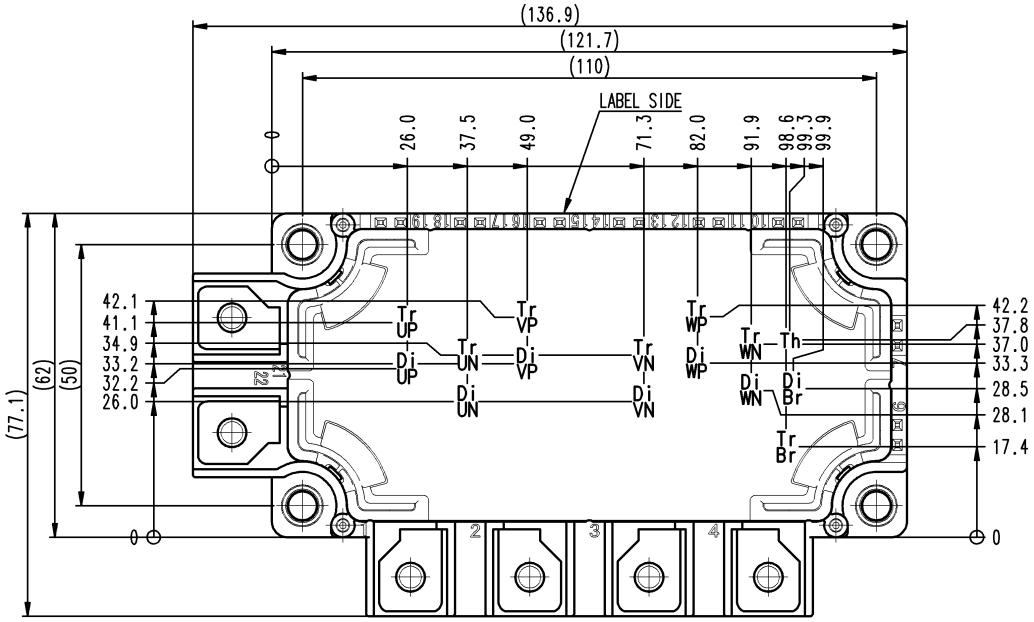
* This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS).

RECOMMENDED OPERATING CONDITIONS

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
V_{CC}	(DC) Supply voltage	Applied across P-N terminals		-	600	850	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across GB-EB/ G*P-E*P/G*N-E*N(*=U, V, W) terminals		13.5	15.0	16.5	V
R_G	External gate resistance	Per switch	Inverter IGBT	6.2	-	62	Ω
			Brake IGBT	13	-	130	

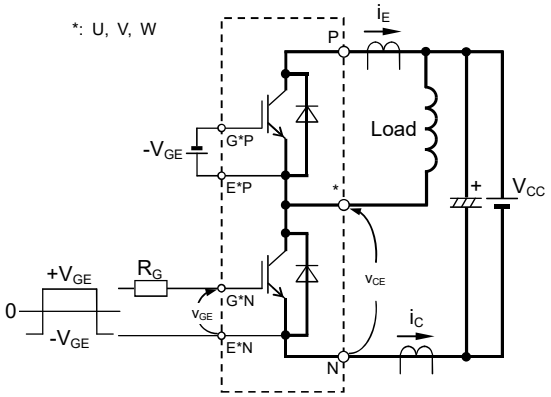
CHIP LOCATION (Top view)

Dimension in mm, tolerance: ±1 mm

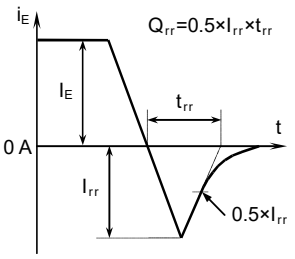


Tr*P/Tr*N/TrBr: IGBT, Di*P/Di*N: DIODE (*=U/V/W), DiBr: Brake DIODE, Th: NTC thermistor

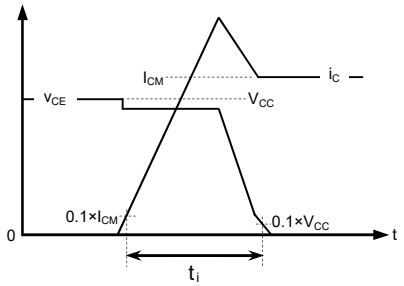
TEST CIRCUIT AND WAVEFORMS



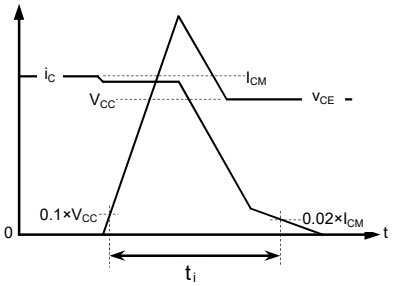
Switching test circuit and waveforms



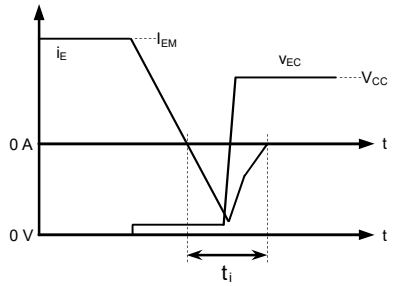
trr, Qrr test waveform



IGBT Turn-on switching energy



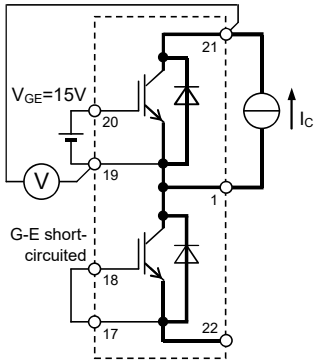
IGBT Turn-off switching energy



DIODE Reverse recovery energy

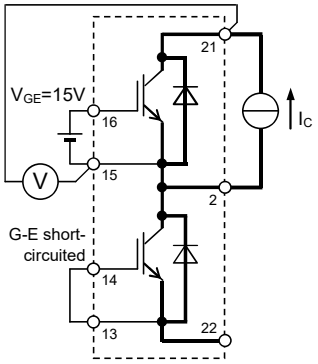
Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

TEST CIRCUIT



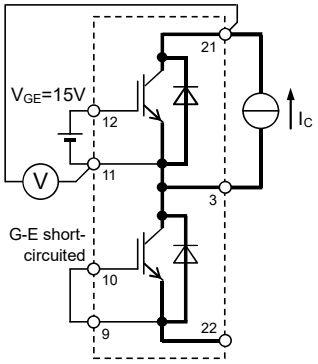
Gate-emitter short-circuited GVP-EVP GVN-EVN, GWP-EWP, GWN-EWN, GB-EB

UP / UN IGBT



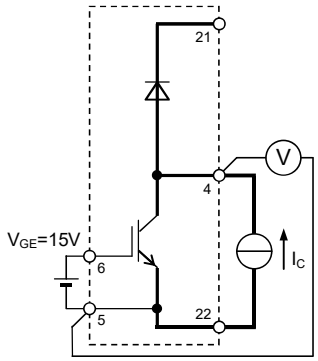
Gate-emitter short-circuited GUP-EUP, GUN-EUN, GWP-EWP, GWN-EWN, GB-EB

VP / VN IGBT



Gate-emitter short-circuited GUP-EUP, GUN-EUN, GVP-EVP, GVN-EVN, GB-EB

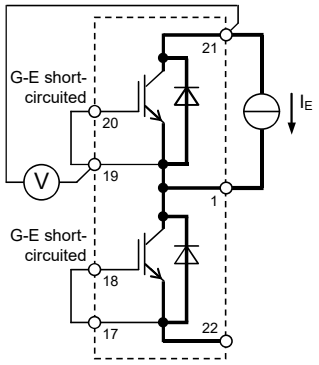
WP / WN IGBT



Gate-emitter short-circuited GUP-EUP, GUN-EUN, GVP-EVP, GVN-EVN, GWP-EWP, GWN-EWN

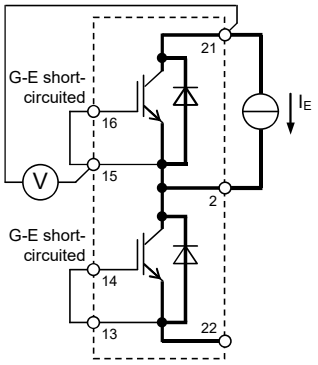
Brake IGBT

V_{CEsat} characteristics test circuit



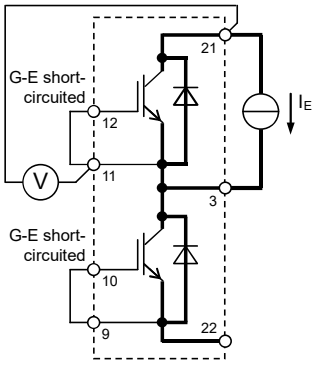
Gate-emitter short-circuited GVP-EVP GVN-EVN, GWP-EWP, GWN-EWN, GB-EB

UP / UN DIODE



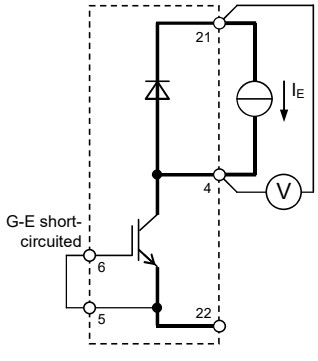
Gate-emitter short-circuited GUP-EUP, GUN-EUN, GWP-EWP, GWN-EWN, GB-EB

VP / VN DIODE



Gate-emitter short-circuited GUP-EUP, GUN-EUN, GVP-EVP, GVN-EVN, GB-EB

WP / WN DIODE



Gate-emitter short-circuited GUP-EUP, GUN-EUN, GVP-EVP, GVN-EVN, GWP-EWP, GWN-EWN

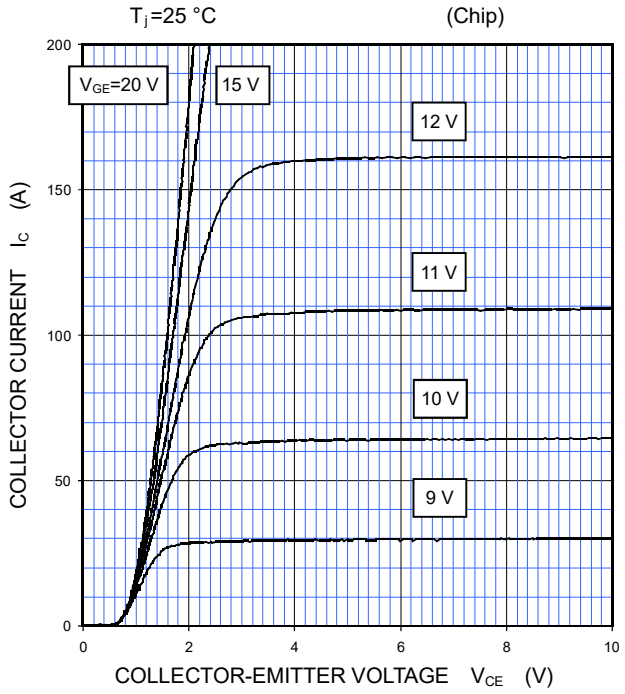
Brake DIODE

V_{EC} / V_F characteristics test circuit

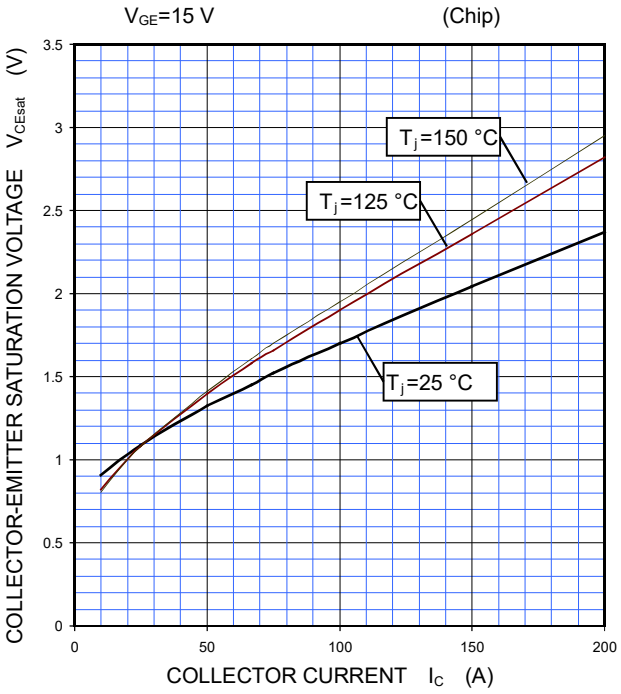
PERFORMANCE CURVES

INVERTER PART

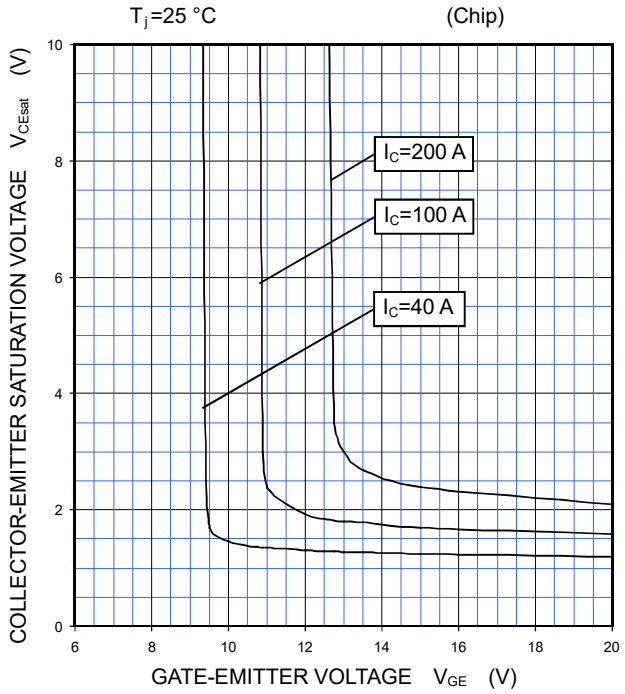
OUTPUT CHARACTERISTICS (TYPICAL)



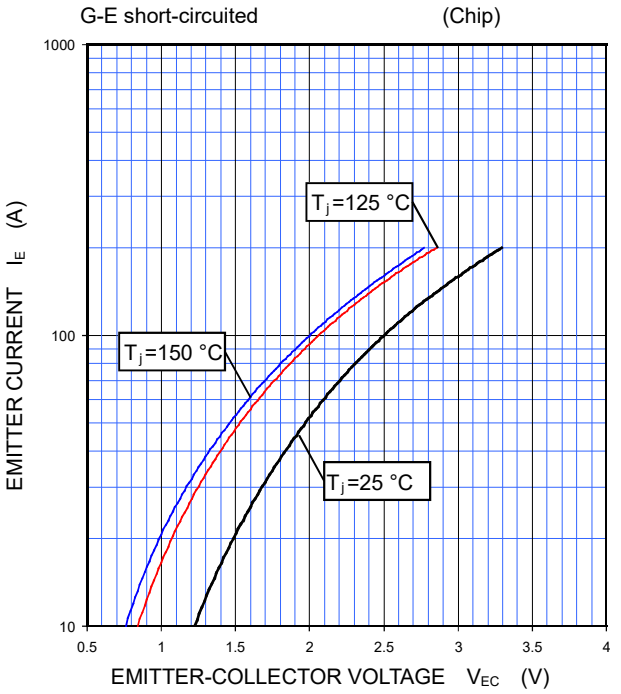
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)

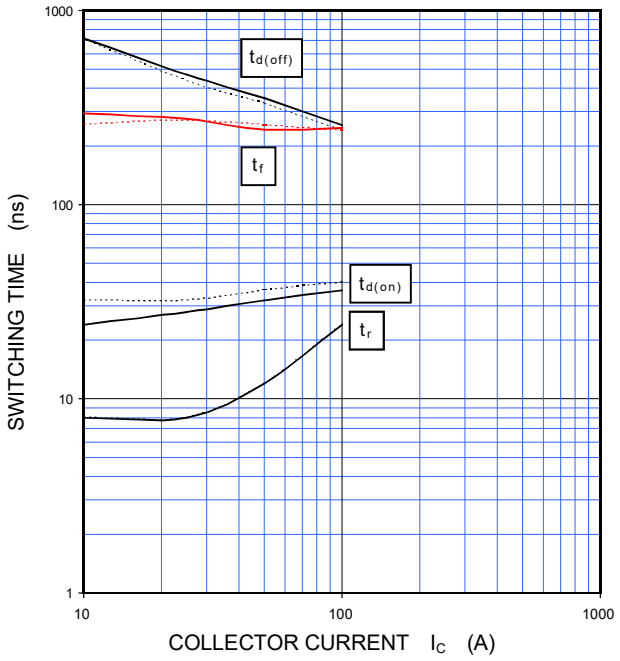


PERFORMANCE CURVES

INVERTER PART

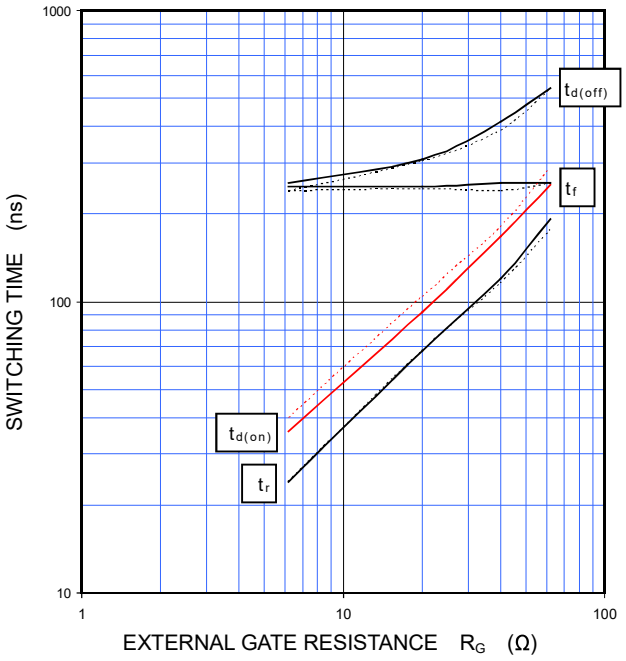
HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)

V_{CC}=600 V, V_{GE}=±15 V, R_G=6.2 Ω, INDUCTIVE LOAD
————: T_j=150 °C, - - - - -: T_j=125 °C

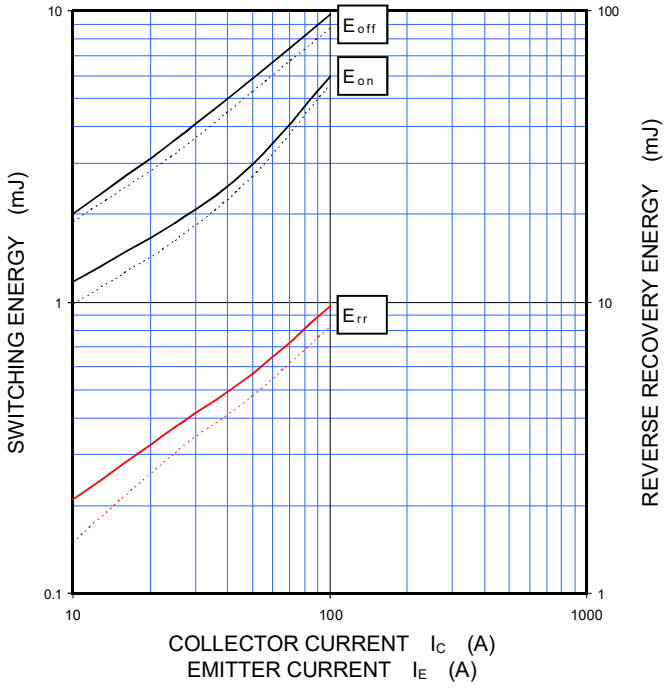


HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)

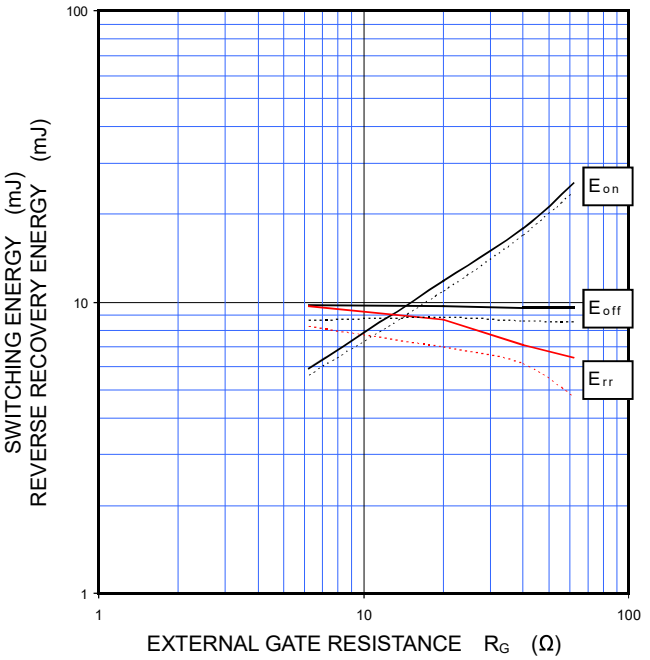
V_{CC}=600 V, V_{GE}=±15 V, I_C=100 A, INDUCTIVE LOAD
————: T_j=150 °C, - - - - -: T_j=125 °C



HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)
V_{CC}=600 V, V_{GE}=±15 V, R_G=6.2 Ω,
INDUCTIVE LOAD, PER PULSE
————: T_j=150 °C, - - - - -: T_j=125 °C



HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)
V_{CC}=600 V, V_{GE}=±15 V, I_C/I_E=100 A,
INDUCTIVE LOAD, PER PULSE
————: T_j=150 °C, - - - - -: T_j=125 °C

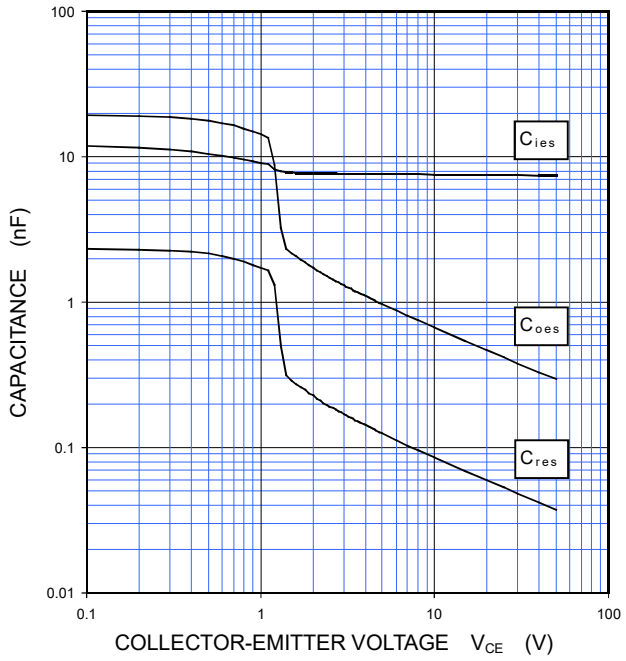


PERFORMANCE CURVES

INVERTER PART

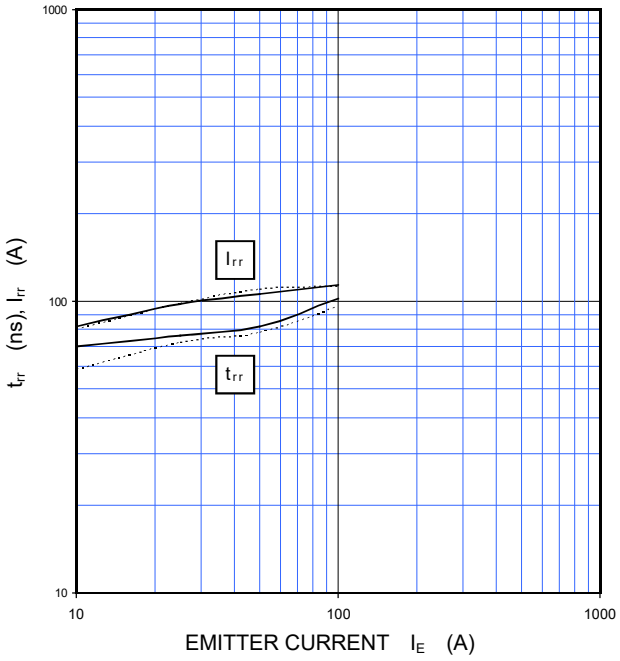
CAPACITANCE
CHARACTERISTICS
(TYPICAL)

G-E short-circuited, T_j=25 °C



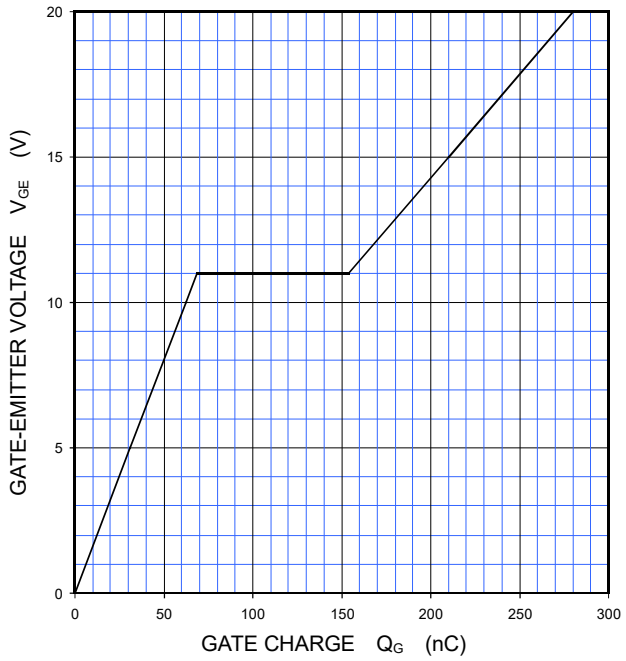
FREE WHEELING DIODE
REVERSE RECOVERY CHARACTERISTICS
(TYPICAL)

V_{CC}=600 V, V_{GE}=±15 V, R_G=6.2 Ω, INDUCTIVE LOAD
————: T_j=150 °C, - - - - -: T_j=125 °C

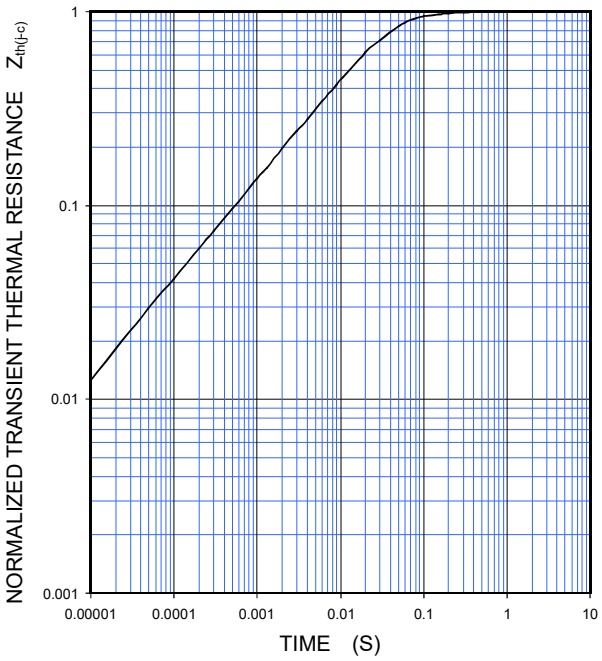


GATE CHARGE
CHARACTERISTICS
(TYPICAL)

V_{CC}=600 V, I_C=100 A, T_j=25 °C



TRANSIENT THERMAL IMPEDANCE
CHARACTERISTICS
(MAXIMUM)
Single pulse, T_C=25 °C
$R_{th(j-c)Q}$=0.24 K/W, $R_{th(j-c)D}$=0.37 K/W

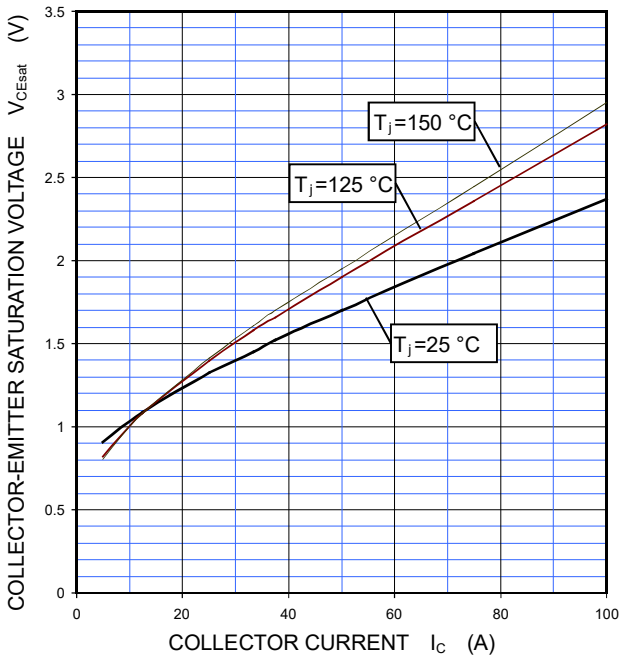


PERFORMANCE CURVES

BRAKE PART

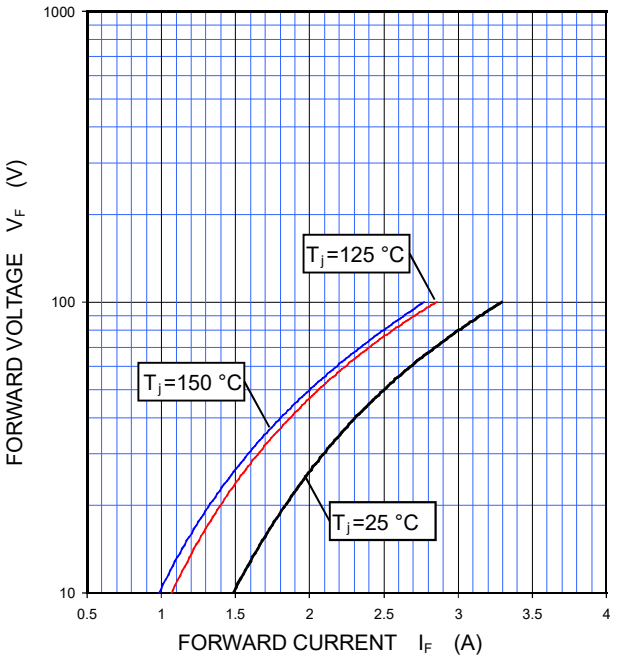
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)

V_{GE}=15 V (Chip)



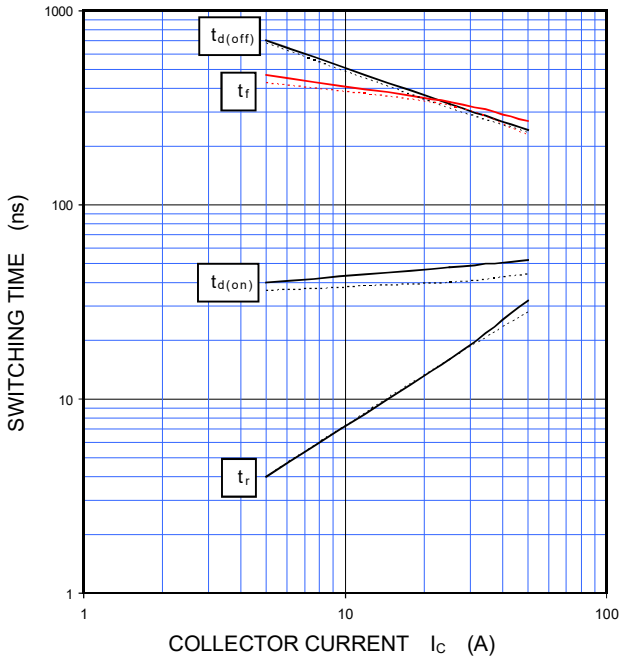
CLAMP DIODE FORWARD CHARACTERISTICS (TYPICAL)

G-E short-circuited (Chip)



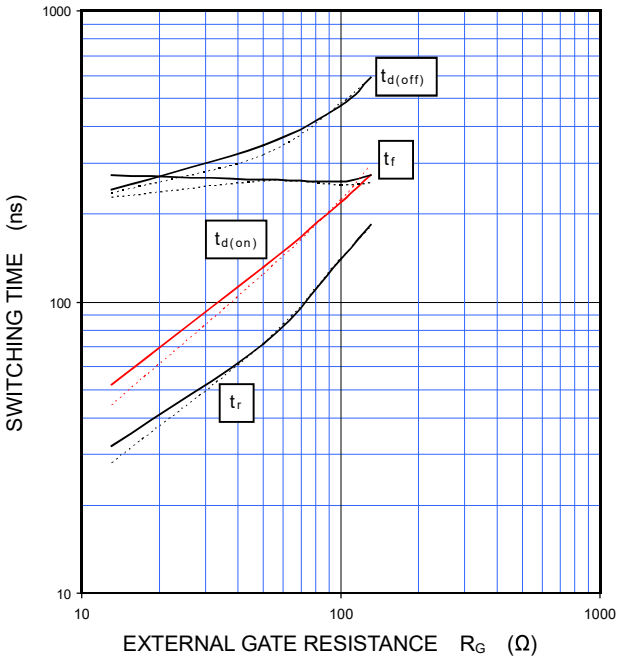
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, V_{GE}=±15 V, R_G=13 Ω, INDUCTIVE LOAD
————: T_j=150 °C, - - - - -: T_j=125 °C



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

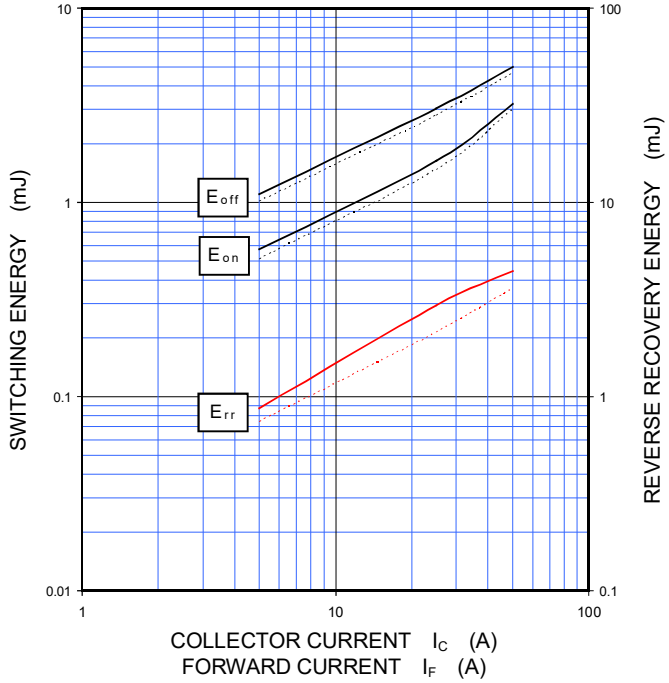
V_{CC}=600 V, I_C=50 A, V_{GE}=±15 V, INDUCTIVE LOAD
————: T_j=150 °C, - - - - -: T_j=125 °C



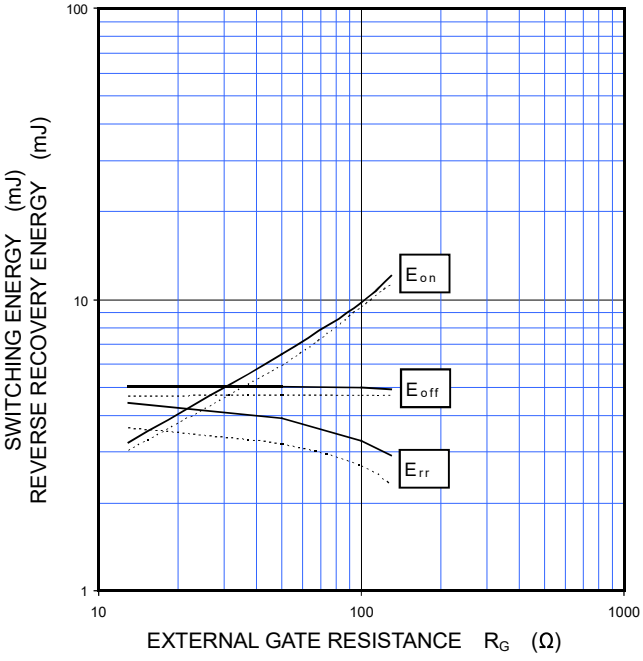
PERFORMANCE CURVES

BRAKE PART

HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)
V_{CC}=600 V, V_{GE}=±15 V, R_G=13 Ω,
INDUCTIVE LOAD, PER PULSE
————: T_j=150 °C, - - - - -: T_j=125 °C

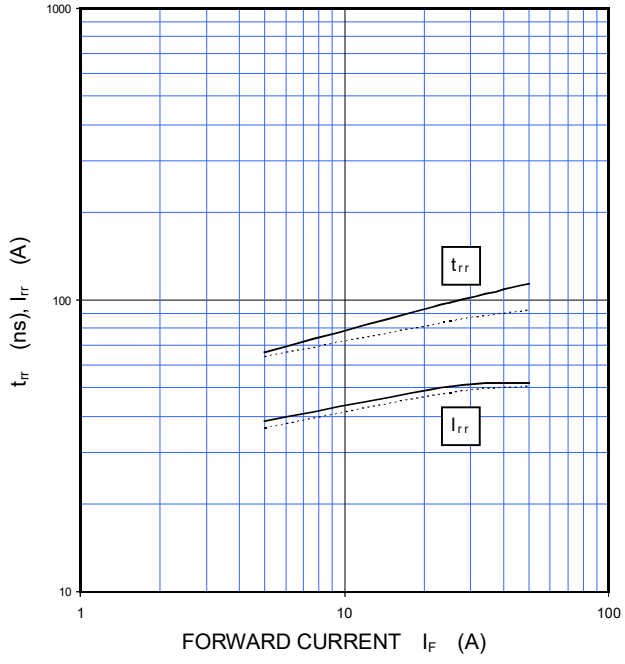


HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)
V_{CC}=600 V, I_C/I_F=50 A, V_{GE}=±15 V,
INDUCTIVE LOAD, PER PULSE
————: T_j=150 °C, - - - - -: T_j=125 °C



BRAKE DIODE
REVERSE RECOVERY CHARACTERISTICS
(TYPICAL)

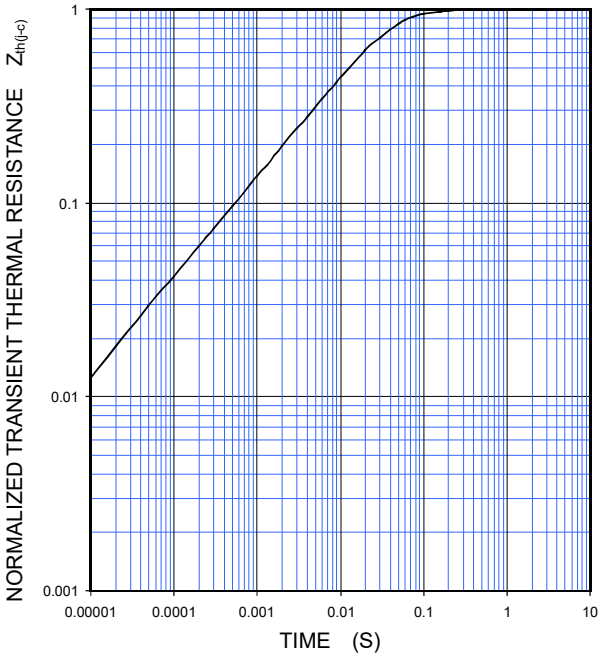
V_{CC}=600 V, V_{GE}=±15 V, R_G=13 Ω, INDUCTIVE LOAD
————: T_j=150 °C, - - - - -: T_j=125 °C



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS

(MAXIMUM)

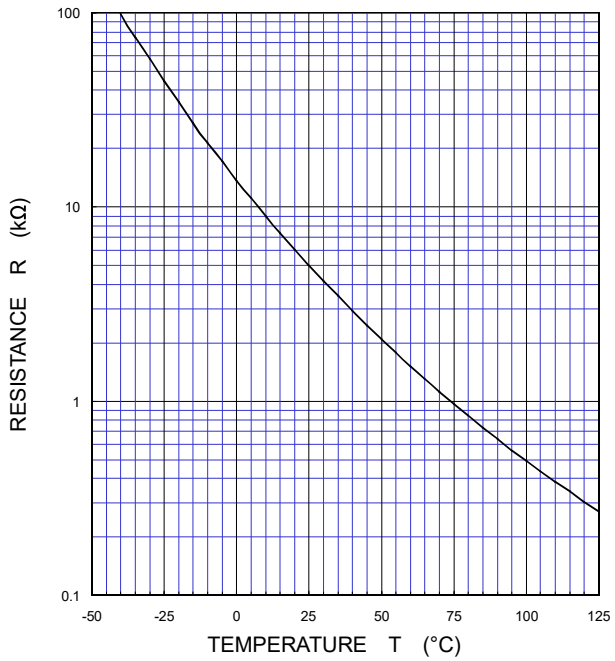
Single pulse, T_C=25 °C
$R_{th(j-c)Q}$=0.44 K/W, $R_{th(j-c)D}$=0.66 K/W



PERFORMANCE CURVES

NTC thermistor part

TEMPERATURE CHARACTERISTICS (TYPICAL)



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